International Rectifier

AUIRFR4292 AUIRFU4292

HEXFET® Power MOSFET

Features

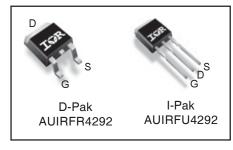
- Advanced Process Technology
- Low On-Resistance
- 175°C Operating Temperature
- Fast Switching
- Repetitive Avalanche Allowed up to Tjmax
- Lead-Free, RoHS Compliant
- Automotive Qualified *

G S

V _{(BR)DSS}	250V
R _{DS(on)} typ.	275m $Ω$
max.	345m $Ω$
I _D	9.3A

Description

Specifically designed for Automotive applications, this HEXFET® Power MOSFET utilizes the latest processing techniques to achieve extremely low on-resistance per silicon area. Additional features of this design are a 175°C junction operating temperature, fast switching speed and improved repetitive avalanche rating. These features combine to make this design an extremely efficient and reliable device for use in Automotive applications and a wide variety of other applications.



G	D	S
Gate	Drain	Source

Absolute Maximum Ratings

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only; and functional operation of the device at these or any other condition beyond those indicated in the specifications is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability. The thermal resistance and power dissipation ratings are measured under board mounted and still air conditions. Ambient temperature (T_A) is 25°C, unless otherwise specified.

	Parameter	Max.	Units
I _D @ T _C = 25°C	Continuous Drain Current, V _{GS} @ 10V	9.3	
I _D @ T _C = 100°C	Continuous Drain Current, V _{GS} @ 10V	6.6	Α
I _{DM}	Pulsed Drain Current ①	40	
P _D @T _C = 25°C	Power Dissipation	100	W
	Linear Derating Factor	0.67	W/°C
V_{GS}	Gate-to-Source Voltage	± 20	V
E _{AS}	Single Pulse Avalanche Energy (Thermally Limited) ②	130	mJ
E _{AS} (tested)	Single Pulse Avalanche Energy Tested Value ®	97	
I _{AR}	Avalanche Current ①	See Fig.12a, 12b, 15, 16	Α
E _{AR}	Repetitive Avalanche Energy ⑤		mJ
TJ	Operating Junction and	-55 to + 175	
T _{STG}	Storage Temperature Range		°C
	Soldering Temperature, for 10 seconds (1.6mm from case)	300	

Thermal Resistance

merma recolcance								
	Parameter	Тур.	Max.	Units				
$R_{\theta JC}$	Junction-to-Case ®		1.5	°C/W				
$R_{\theta JA}$	Junction-to-Ambient (PCB Mount) ♡		50					
$R_{\theta JA}$	Junction-to-Ambient		110					

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^{*}Qualification standards can be found at http://www.irf.com/

Static Electrical Characteristics @ T_J = 25°C (unless otherwise specified)

	Parameter	Min.	Тур.	Max.	Units	Conditions
V _{(BR)DSS}	Drain-to-Source Breakdown Voltage	250			V	$V_{GS} = 0V, I_D = 250\mu A$
$\Delta V_{(BR)DSS}/\Delta T_J$	Breakdown Voltage Temp. Coefficient		0.31		V/°C	Reference to 25°C, I _D = 1.0mA
R _{DS(on)}	Static Drain-to-Source On-Resistance	_	275	345	mΩ	$V_{GS} = 10V, I_D = 5.6A$ ③
$V_{GS(th)}$	Gate Threshold Voltage	3.0		5.0	V	$V_{DS} = V_{GS}$, $I_D = 50\mu A$
gfs	Forward Transconductance	6.2			V	$V_{DS} = 50V, I_D = 5.6A$
I _{DSS}	Drain-to-Source Leakage Current	_		20	μΑ	$V_{DS} = 250V, V_{GS} = 0V$
				250		$V_{DS} = 250V, V_{GS} = 0V, T_{J} = 125^{\circ}C$
I _{GSS}	Gate-to-Source Forward Leakage			100	nA	$V_{GS} = 20V$
	Gate-to-Source Reverse Leakage			-100		$V_{GS} = -20V$

Dynamic Electrical @ T_{.I} = 25°C (unless otherwise specified)

	Parameter	Min.	Тур.	Max.	Units	Conditions
Q_g	Total Gate Charge	l —	13	20		I _D = 5.6A
Q_{gs}	Gate-to-Source Charge		4.7		nC	V _{DS} = 125V
Q_{gd}	Gate-to-Drain ("Miller") Charge		4.8			V _{GS} = 10V ③
t _{d(on)}	Turn-On Delay Time		11			V _{DD} = 250V
t _r	Rise Time		15			$I_D = 5.6A$
t _{d(off)}	Turn-Off Delay Time		16		ns	$R_G = 15\Omega$
t _f	Fall Time		8.4			V _{GS} = 10V ③
L _D	Internal Drain Inductance	_	4.5	_		Between lead,
					nΗ	6mm (0.25in.)
Ls	Internal Source Inductance		7.5			from package
						and center of die contact
C _{iss}	Input Capacitance		705			$V_{GS} = 0V$
Coss	Output Capacitance		71			$V_{DS} = 25V$
C _{rss}	Reverse Transfer Capacitance		20		pF	f = 1.0MHz
Coss	Output Capacitance		600			$V_{GS} = 0V, V_{DS} = 1.0V, f = 1.0MHz$
Coss	Output Capacitance		26			$V_{GS} = 0V, V_{DS} = 200V, f = 1.0MHz$
C _{oss} eff.	Effective Output Capacitance		65			$V_{GS} = 0V, V_{DS} = 0V \text{ to } 200V $

Diode Characteristics

	Parameter	Min.	Тур.	Max.	Units	Conditions
IS	Continuous Source Current			9.3		MOSFET symbol
	(Body Diode)				Α	showing the
I _{SM}	Pulsed Source Current			40		integral reverse
	(Body Diode) ①					p-n junction diode.
V_{SD}	Diode Forward Voltage			1.3	V	$T_J = 25^{\circ}C$, $I_S = 5.6A$, $V_{GS} = 0V$ ③
t _{rr}	Reverse Recovery Time		110	165	ns	$T_J = 25^{\circ}C$, $I_F = 5.6A$, $V_{DD} = 125V$
Q_{rr}	Reverse Recovery Charge		390	585	nC	di/dt = 100A/μs ^③
t _{on}	Forward Turn-On Time	Intrinsic turn-on time is negligible (turn-on is abminated by LS+LD)				

Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature. (See fig. 11).
- ② Limited by T_{Jmax} , starting $T_J = 25^{\circ}C$, L = 8.1 mH $R_G = 50\Omega$, $I_{AS} = 5.6 A$, $V_{GS} = 10 V$. Part not recommended for use above this value.

- S Limited by T_{Jmax}, see Fig.12a, 12b, 15, 16 for typical repetitive avalanche performance.
- ® This value is determined from sample failure population, starting $T_J = 25^{\circ}C$, L = 8.1mH, $R_G = 50Ω$, $I_{AS} = 5.6A$, $V_{GS} = 10V$.

- When mounted on 1" square PCB (FR-4 or G-10 Material). For recommended footprint and soldering techniques refer to application note #AN-994.
- $\ensuremath{\$}\ensuremath{R_{\theta}}$ is measured at T_J approximately 90°C.

Qualification Information[†]

		Automotive					
Qualification Level		(per AEC-Q101)					
		Comments: This part number(s) passed Automotive qualification. IR's Industrial and Consumer qualification level is granted by extension of the higher Automotive level.					
Mariana Caratti ta Land		D-PAK	MSL1				
Moisture Sensi	illivity Level	I-PAK	N/A				
	Machine Model	Class M1B (+/- 100V) ^{††}					
		AEC-Q101-002					
FOR	Human Body Model	Class H1A (+/- 500V) ^{††}					
ESD		AEC-Q101-001					
	Charged Device Model	Class C5 (+/- 2000V) ^{††}					
		AEC-Q101-005					
RoHS Complia	nt			Yes			

[†] Qualification standards can be found at International Rectifier's web site: http://www.irf.com/

^{††} Highest passing voltage.

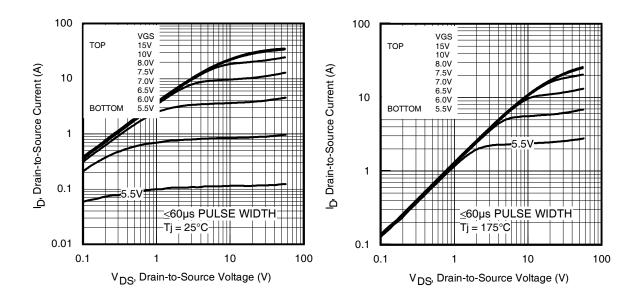


Fig 1. Typical Output Characteristics

Fig 2. Typical Output Characteristics

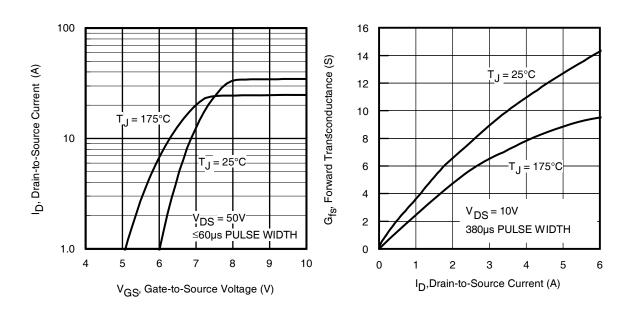


Fig 3. Typical Transfer Characteristics

Fig 4. Typical Forward Transconductance vs. Drain Current

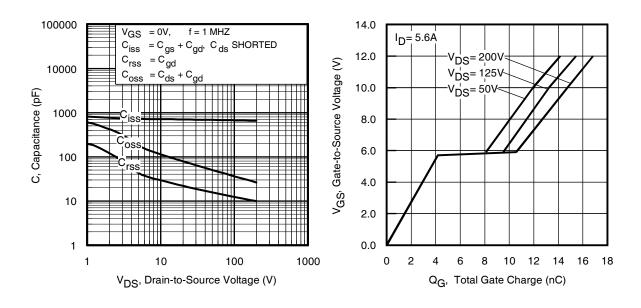


Fig 5. Typical Capacitance vs. Drain-to-Source Voltage

Fig 6. Typical Gate Charge vs. Gate-to-Source Voltage

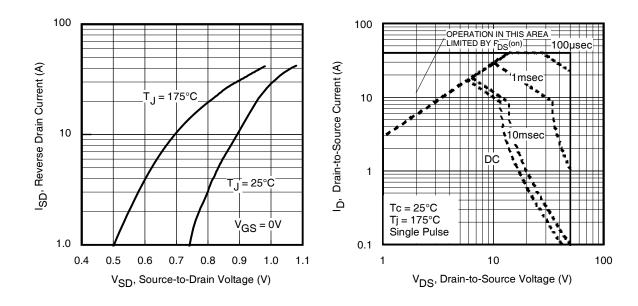


Fig 7. Typical Source-Drain Diode Forward Voltage

Fig 8. Maximum Safe Operating Area

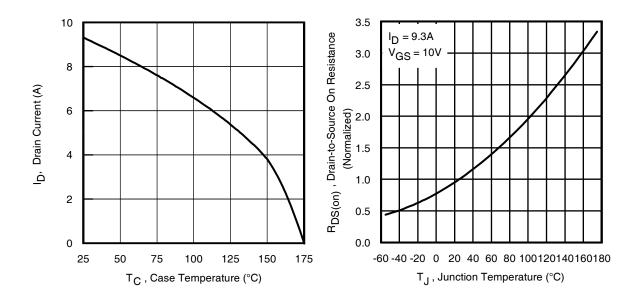


Fig 9. Maximum Drain Current vs. Case Temperature

Fig 10. Normalized On-Resistance vs. Temperature

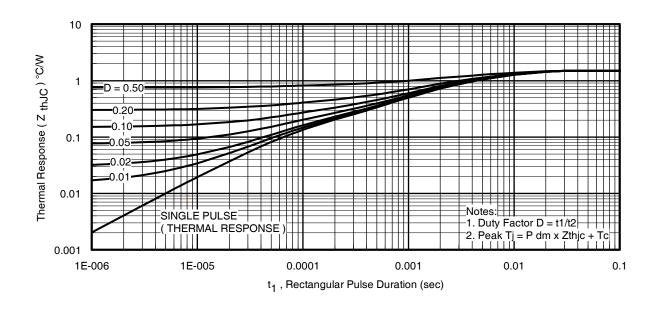


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case

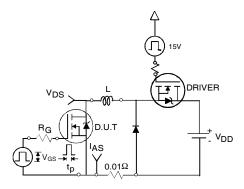


Fig 12a. Unclamped Inductive Test Circuit

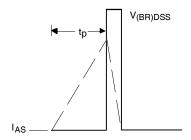


Fig 12b. Unclamped Inductive Waveforms

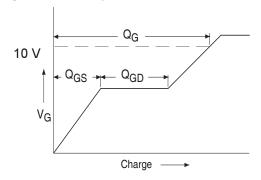


Fig 13a. Basic Gate Charge Waveform

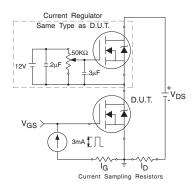


Fig 13b. Gate Charge Test Circuit

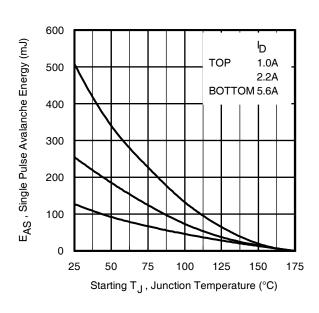


Fig 12c. Maximum Avalanche Energy vs. Drain Current

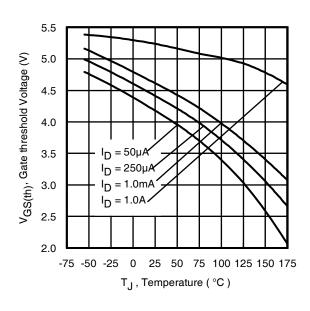


Fig 14. Threshold Voltage vs. Temperature

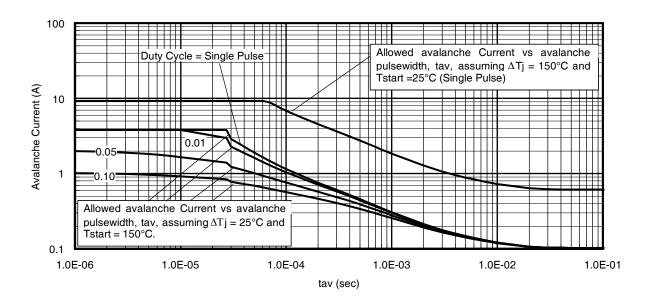


Fig 15. Typical Avalanche Current vs. Pulsewidth

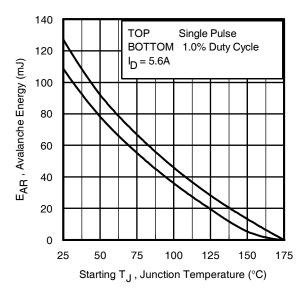


Fig 16. Maximum Avalanche Energy vs. Temperature

Notes on Repetitive Avalanche Curves, Figures 15, 16: (For further info, see AN-1005 at www.irf.com)

- Avalanche failures assumption: Purely a thermal phenomenon and failure occurs at a temperature far in excess of T_{jmax}. This is validated for every part type.
- 2. Safe operation in Avalanche is allowed as long asT_{jmax} is not exceeded.
- 3. Equation below based on circuit and waveforms shown in Figures 12a, 12b.
- P_{D (ave)} = Average power dissipation per single avalanche pulse.
- 5. BV = Rated breakdown voltage (1.3 factor accounts for voltage increase during avalanche).
- 6. I_{av} = Allowable avalanche current.
- 7. ΔT = Allowable rise in junction temperature, not to exceed T_{jmax} (assumed as 25°C in Figure 15, 16). t_{av} = Average time in avalanche. D = Duty cycle in avalanche = t_{av} ·f $Z_{thJC}(D, t_{av})$ = Transient thermal resistance, see figure 11)

$$\begin{split} P_{D \text{ (ave)}} &= 1/2 \text{ (} 1.3 \cdot \text{BV} \cdot I_{av} \text{)} = \triangle \text{T} / Z_{thJC} \\ I_{av} &= 2\triangle \text{T} / \left[1.3 \cdot \text{BV} \cdot Z_{th} \right] \\ E_{AS \text{ (AR)}} &= P_{D \text{ (ave)}} \cdot t_{av} \end{split}$$

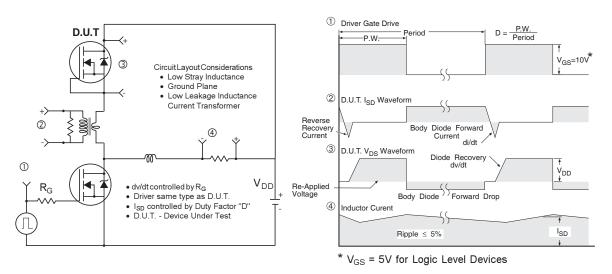


Fig 17. Peak Diode Recovery dv/dt Test Circuit for N-Channel HEXFET® Power MOSFETs

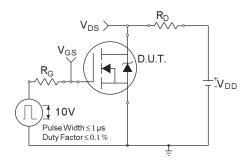


Fig 18a. Switching Time Test Circuit

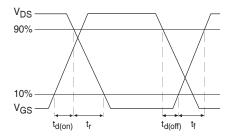
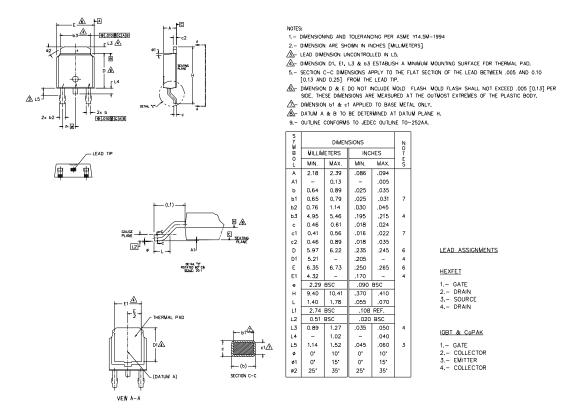


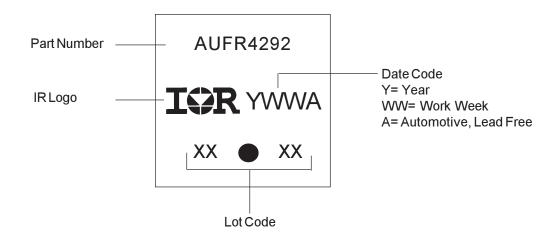
Fig 18b. Switching Time Waveforms

D-Pak (TO-252AA) Package Outline

Dimensions are shown in millimeters (inches)



D-Pak (TO-252AA) Part Marking Information

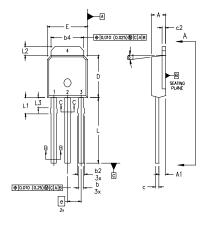


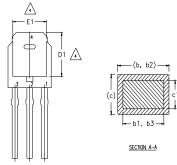
Note: For the most current drawing please refer to IR website at http://www.irf.com/package/

AUIRFR/U4292

I-Pak (TO-251AA) Package Outline

Dimensions are shown in millimeters (inches)





NOTES:

- DIMENSIONING AND TOLERANCING PER ASME Y14.5 M- 1994.
 DIMENSIONIS ARE SHOWN IN MILLIMETERS [INCHES].
 DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED
 0.005 (0.127) PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTERMOST
 EXTREMES OF THE PLASTIC BODY.
 THERMAL PAD CONTOUR OPTION WITHIN DIMENSION 64, L2, E1 & D1.
 LEAD DIMENSION LINCONTROLLED IN L3.

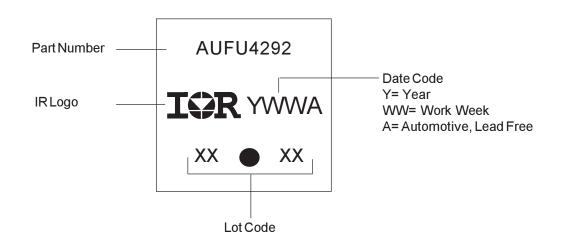
- DIMENSION 61, 63 APPLY TO BASE METAL ONLY, OUTLINE CONFORMS TO JEDEC OUTLINE TO-251AA.
- CONTROLLING DIMENSION: INCHES.

	DIMENSIONS						
SYMBOL	VILLIVETERS		INC	HES			
	Min.	MAX.	MIN.	MAX.	NOTES		
A	2,18	2.39	0.086	.094			
Af	0.89	1,14	0.035	0.045			
b	0.64	0.89	0.025	0.035			
ь1	0.64	0.79	0.025	0,031	4		
b2	0.76	1,14	0.030	0.045			
b3	0.76	1,04	0,030	0,041			
b4	5,00	5.46	0,195	0.215	4		
С	0,46	0.61	0.018	0,024			
c1	0.41	0.56	0.016	0.022			
c2	.046	0.86	0.018	0.035			
D	5.97	6.22	0.235	0.245	3, 4		
D1	5,21	-	0,205	-	4		
Ε	6,35	6,73	0,250	0,265	3, 4		
E1	4,32	-	0,170	-	4		
e	2.	29	0.090	BSC			
L	8.89	9.60	0.350	0.380			
Lf	1,91	2.29	0.075	0.090			
L2	0.89	1,27	0,035	0,050	4		
L3	1.14	1,52	0,045	0,060	5		
61	ď	15"	σ	15*			
			ll .		l		

LEAD ASSIGNMENTS

HE)	HEXFEI					
1,-	GATE					
2,-	DRAIN					
3	SOURCE					
	DDAIN					

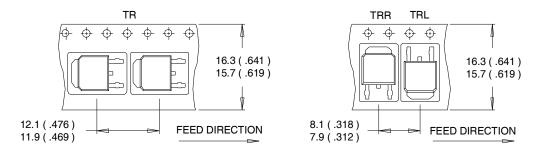
I-Pak (TO-251AA) Part Marking Information



Note: For the most current drawing please refer to IR website at http://www.irf.com/package/

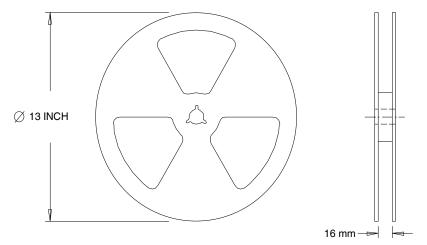
D-Pak (TO-252AA) Tape & Reel Information

Dimensions are shown in millimeters (inches)



NOTES:

- 1. CONTROLLING DIMENSION: MILLIMETER.
- 2. ALL DIMENSIONS ARE SHOWN IN MILLIMETERS (INCHES).
- 3. OUTLINE CONFORMS TO EIA-481 & EIA-541.



NOTES:

1. OUTLINE CONFORMS TO EIA-481.

Ordering Information

Base part number	Package Type	Standard Pack		Complete Part Number
		Form	Quantity	
AUIRFR4292	DPak	Tube	75	AUIRFR4292
		Tape and Reel	2000	AUIRFR4292TR
		Tape and Reel Left	3000	AUIRFR4292TRL
		Tape and Reel Right	3000	AUIRFR4292TRR
AUIRFU4292	IPak	Tube	75	AUIRFU4292

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For technical support, please contact IR's Technical Assistance Center http://www.irf.com/technical-info/

WORLDHEADQUARTERS:

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